

Notice of References Cited	Application/Control No. 09/910,432		Applicant(s)/Patent Under Reexamination WAUGH ET AL.	
	Examiner Richard Schnizer, Ph. D.		Art Unit 1635	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,008,924	03-2006	Yan et al.	514/12
*	B	US-5,989,545	11-1999	Foster et al.	424/183.1
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 96/11712	04-1996	WO	Kayyem et al	----
	O					
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	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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